


<b>Search Notes</b>  	<b>Application/Control No.</b>  10027302	<b>Applicant(s)/Patent Under Reexamination</b>  BOUET, STEPHANE
	<b>Examiner</b>  Dalencourt, Yves	<b>Art Unit</b>  2157

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
WEST (updated text search)	06/27/2007	YD
WEST (updated text search)	07/02/2007	YD
STIC (EIC Search)	06/28/2007	YD
WEST (updated text search)	12/23/2007	YD
WEST (updated text search)	06/22/2008	YD

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner